

**Search Notes**

Application/Control No.

10/759,400

Examiner

Paul Dinh

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	4-6, 10-12	10/20/2005	PD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	4-5	10/20/2005	PD

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, IEEE	10/20/2005	PD